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IR-2281 (2-3807)

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Patent Application of

New York, New York

Chik Yam LEE

Date: May 16, 2005

Serial No.: 10/713,928

Group Art Unit: 2816

Filed: November 14, 2003

Examiner: Anh Quan Tra

For: TEMPERATURE COMPENSATED BANDGAP VOLTAGE REFERENCES

Mail Stop Amendment
Commissioner for Patents
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SUBMISSION

Sir:

Submitted herewith is a copy of a search report issued by a patent searching authority other than the PTO and the cited art together with a form listing the same for the convenience of the Examiner.

I certify that each item of information contained in this Submission was cited in a communication from a foreign patent office in a counterpart foreign application and that this communication was not received by any individual designated in 37 C.F.R. 1.56(c) more than 30 days prior to the filing of this Submission.

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Respectfully submitted,

James A. Finder

Name of applicant, assignee or
Registered Representative

Signature

May 16, 2005

Date of Signature

James A. Finder

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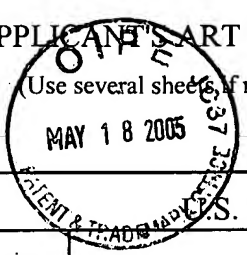
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Enclosures

APPLICANT'S ART CITATION (Use several sheets, if necessary) 		Application 10/713,928		OFGS File No. IR-2281 (2-3807)			
		Applicant Chik Yam Lee					
		Filing Date November 14, 2003		Group Art Unit 2816			
U.S. PATENT DOCUMENTS (not submitted for applications filed after 6/30/03)							
Examiner Initial	Document Number	Date MM-YYYY	Name	Class	Sub-class	Filing Date If Appropriate	
	US-5,686,823	11-1997	Rapp et al.				
	US-5,394,078	02-1995	Brokaw et al.				
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FOREIGN PATENT DOCUMENTS							
	Document Number	Date MM-YYYY	Country	Class	Sub-class	Translation	
						Yes	No
	2002-108467	04-2002	JAPAN			X	
	97/44722	11-1997	PCT			X	
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)							
Examiner		Date Considered					
EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the applicant.							